

SIOV metal oxide varistors

Housed (ThermoFuse) varistors, AdvanceD series

Series/Type:ETFV25Date:January 2018

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ThermoFuse varistors, ETFV25 series

Construction

- Round varistor element, leaded
- Coating: epoxy resin, flame-retardant to UL 94 V-0
- Terminals: tinned copper wire, metal compound wire
- Housing: thermoplastic, flame-retardant to UL 94 V-0

Features

- Wide operating voltage range 115 ... 420 V_{RMS}
- Self-protected under abnormal overvoltage conditions
- Very high surge current ratings of 20 kA

Approvals

- UL 🛛
- IEC
- VDE

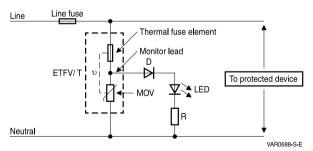
Applications

- Air conditioner, refrigerator, TV, etc.
- Power meter, inverter, telecom equipment, etc.
- Transient voltage surge suppressors (TVSS)
- Solar inverter

Delivery mode

Bulk (standard)

Typical applications



General technical data

Climatic category	to IEC 60068-1	40/85/56	
Operating temperature	to IEC 61051	-40 + 85	°C
Storage temperature		-40 + 85	°C
Electric strength	to IEC 61051	≥ 2.5	kV _{RMS}
Insulation resistance	to IEC 61051	≥ 100	MΩ

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Electrical specifications and ordering codes

Maximum ratings ($T_A = 85 \ ^{\circ}C$)

Ordering code	Туре	V _{RMS}	V _{DC}	i _{max} 1)	l _n ²⁾	W _{max}	P _{max}
	(untaped)			(8/20 µs)	(8/20 µs)	(2 ms)	
	SIOV-				15 times		
		V	V	А	A	J	W
B72225T4111K101	ETFV25K115E4	115	150	20000	10000	170	1.0
B72225T4131K101	ETFV25K130E4	130	170	20000	10000	185	1.0
B72225T4141K101	ETFV25K140E4	140	180	20000	10000	195	1.0
B72225T4151K101	ETFV25K150E4	150	200	20000	10000	215	1.0
B72225T4171K101	ETFV25K175E4	175	225	20000	10000	245	1.0
B72225T4211K101	ETFV25K210E4	210	270	20000	10000	290	1.0
B72225T4231K101	ETFV25K230E4	230	300	20000	10000	315	1.0
B72225T4251K101	ETFV25K250E4	250	320	20000	10000	345	1.0
B72225T4271K101	ETFV25K275E4	275	350	20000	10000	375	1.0
B72225T4301K101	ETFV25K300E4	300	385	20000	10000	410	1.0
B72225T4321K101	ETFV25K320E4	320	420	20000	10000	445	1.0
B72225T4351K101	ETFV25K350E4	350	460	20000	10000	495	1.0
B72225T4381K101	ETFV25K385E4	385	505	20000	10000	600	1.0
B72225T4421K101	ETFV25K420E4	420	560	20000	10000	700	1.0

Characteristics (T_A = 25 $^{\circ}$ C)

Ordering code	Туре	Vv	ΔV_{v}	V _{c,max}	i _c	C _{typ}
-	(untaped)	(1 mA)	(1 mA)	(i _c)		(1 kHz)
	SIOV-	V	%	V	А	pF
B72225T4111K101	ETFV25K115E4	180	±10	300	150	2280
B72225T4131K101	ETFV25K130E4	205	±10	340	150	2010
B72225T4141K101	ETFV25K140E4	220	±10	360	150	1860
B72225T4151K101	ETFV25K150E4	240	±10	395	150	1740
B72225T4171K101	ETFV25K175E4	270	±10	455	150	1500
B72225T4211K101	ETFV25K210E4	330	±10	545	150	1245
B72225T4231K101	ETFV25K230E4	360	±10	595	150	1140
B72225T4251K101	ETFV25K250E4	390	±10	650	150	1050
B72225T4271K101	ETFV25K275E4	430	±10	710	150	945
B72225T4301K101	ETFV25K300E4	470	±10	775	150	870
B72225T4321K101	ETFV25K320E4	510	±10	840	150	810
B72225T4351K101	ETFV25K350E4	560	±10	910	150	750
B72225T4381K101	ETFV25K385E4	620	±10	1025	150	675
B72225T4421K101	ETFV25K420E4	680	±10	1120	150	630

1) Note: Thermal fuse may form open circuit after 1 impulse @ 20 kA, 8/20 µs test.

2) Note: Nominal discharge current In according to UL 1449, 4th edition.



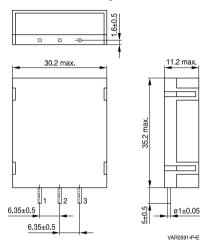
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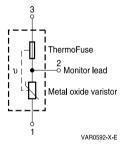
Dimensional drawings



Weight

Nominal diameter	V _{RMS}	Weight
mm	V	g
25	115 420	9.9 18.6

Lead configuration





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Reliability data

Test	Test methods/conditions	Requirement
Varistor voltage	The voltage between two terminals with the specified measuring current applied is called V _v (1 mA _{DC} @ 0.2 2 s).	To meet the specified value
Clamping voltage	The maximum voltage between two terminals with the specified standard impulse current (8/20 µs) applied.	To meet the specified value
Endurance at upper category temperature	1000 h at UCT After having continuously applied the maximum allowable AC voltage at UCT ± 2 °C for 1000 h, the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V _v shall be measured.	ΙΔV/V (1 mA)Ι ≤10%
Surge current derating, 8/20 µs	10 surge currents (8/20 μ s), unipolar, interval 30 s, amplitude corresponding to derating curve for 10 impulses at 20 μ s	I∆V/V (1 mA)I ≤10% (measured in direction of surge current) No visible damage
Surge current derating, 2 ms	10 surge currents (2 ms), unipolar, interval 120 s, amplitude corresponding to derating curve for 10 impulses at 2 ms	IΔV/V (1 mA)I ≤10% (measured in direction of surge current) No visible damage
Electric strength	IEC 61051-1, test 4.9.2 Metal balls method, 2500 V_{RMS} , 60 s The varistor is placed in a container holding 1.6 ±0.2 mm diameter metal	No breakdown
	balls such that only the terminations of the varistor are protruding. The specified voltage shall be applied between both terminals of the specimen connected together and the electrode inserted between the metal balls.	





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Test	Test methods/conditions	Requirement
Climatic sequence	The specimen shall be subjected to: a) dry heat at UCT, 16 h, IEC 60068-2-2, test Ba b) damp heat, 1st cycle: $55 ^{\circ}$ C, 93% r. H., 24 h, IEC 60068-2-30, test Db c) cold, LCT, 2 h, IEC 60068-2-1, test Aa d) damp heat, additional 5 cycles: $55 ^{\circ}$ C/25 $^{\circ}$ C, 93% r. H., 24 h/cycle, IEC 60068-2-30, test Db.	IΔV/V (1 mA)I ≤10% R _{ins} ≥100 MΩ
	Then the specimen shall be stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V_V shall be measured. Thereafter, insulation resis- tance R_{ins} shall be measured at V = 500 V.	
Rapid change of	IEC 60068-2-14, test Na, LCT/UCT,	l∆V/V (1 mA)l ≤5%
temperature	dwell time 30 min, 5 cycles	No visible damage
Damp heat, steady state	IEC 60068-2-78, test Ca	l∆V/V (1 mA)l ≤10%
	The specimen shall be subjected to 40 \pm 2 °C, 90 to 95% r. H. for 56 days without load / with 10% of the maxi- mum continuous DC operating voltage V _{DC} . Then stored at room temperature and normal humidity for 1 to 2 h. Thereafter, the change of V _V shall be measured. Thereafter, insulation resis- tance R _{ins} shall be measured at V = 500 V (insulated varistors only).	R _{ins} ≥100 MΩ

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Test	Test methods/conditions	Requirement
Test Solderability	Test methods/conditions IEC 60068-2-20, test Ta, method 1 with modified conditions for lead-free solder alloys: 245 °C, 3 s: After dipping the terminals to a depth of approximately 3 mm from the body in a soldering bath of 245 °C for 3 s, the terminals shall be visually examined.	Requirement The inspection shall be carried out under adequate light with normal eyesight or with the assistance of a magnification of 4 to 10 times. The dipped surface shall be covered with a smooth and bright solder coating with no more than small amounts of scattered imperfections such as pinholes or un-wetted or de-wetted areas. These imperfections shall not be concentrated in one area.
Resistance to soldering heat	IEC 60068-2-20, test Tb, method 1A, 260 °C, 10 s: Each lead shall be dipped into a solder bath having a temperature of 260 ± 5 °C to a point 2.0 to 2.5 mm from the body of the specimen, be held there for 10 ± 1 s and then be stored at room temperature and normal humidity for 1 to 2 h. The change of V _V shall be measured and the specimen shall be visually examined.	l∆V/V (1 mA)l ≤5% No visible damage
Tensile strength	IEC 60068-2-21, test Ua1 After gradually applying the force specified below and keeping the unit fixed for 10 s, the terminal shall be visually examined for any damage. Force for wire diameter: 0.6 mm = 10 N 0.8 mm = 10 N 1.0 mm = 20 N	IΔV/V (1 mA)I ≤5% No break of solder joint, no wire break





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Test	Test methods/conditions	Requirement
Vibration	IEC 60068-2-6, test Fc, method B4	l∆V/V (1 mA)l ≤5%
	Frequency range: $10 \dots 55 \text{ Hz}$ Amplitude: $0.75 \text{ mm or } 98 \text{ m/s}^2$ Duration: $6 \text{ h} (3 \cdot 2 \text{ h})$ Pulse:sine waveAfter repeatedly applying a single harmonic vibration according to the table above.The change of V _V shall be measured and the specimen shall be visually examined.	No visible damage
Bump	IEC 60068-2-29, test Eb Pulse duration: 6 ms Max. acceleration: 400 m/s ² Number of bumps:4000 Pulse: half sine	l∆V/V (1 mA)l ≤5% No visible damage
Fire hazard	IEC 60695-11-5 (needle flame test) Severity: vertical 10 s	5 s max.



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Test	Test methods/cond	ditions		Re	quirement
Abnormal overvoltage test	The device is designed to meet the limited current abnormal overvoltage condition, outlined in section 39.4 of UL 1449, 4 th edition. Detailed test voltage applied onto the device for different types as in the following table:			sha this	y of these phenomena all not be observed, or s specimen will be judged failed part: Emission of flame, molter metal, glowing or flaming particles through any
	Type ETFV25K115E4 ETFV25K130E4 ETFV25K130E4 ETFV25K150E4 ETFV25K175E4 ETFV25K210E4 ETFV25K230E4 ETFV25K230E4 ETFV25K300E4 ETFV25K320E4 ETFV25K320E4 ETFV25K350E4 ETFV25K385E4 ETFV25K420E4	Device rating V 115 130 140 150 175 210 230 250 275 300 320 350 385 420	Test voltage V 240 260 280 350 420 415 500 480 600 600 600 600 600 600	2. 3. 4.	openings (pre-existed or created as a result of the test) in the product. Charring, glowing, or flaming of the supporting surface, tissue paper, or cheesecloth. Ignition of the enclosure. Creation of any openings in the enclosure that result in accessibility of live parts, when evaluated in accordance with accessibility of live parts test in section 58.2 of UL1449, 4 th edition.

Note:

UCT = Upper category temperature

LCT = Lower category temperature

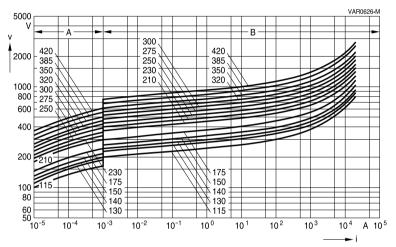
R_{ins} = Insulation resistance





v/i characteristics

v = f (i) for explanation of the characteristics refer to "General technical information", chapter 1.6.3 A = Leakage current, B = Protection level } for worst-case varistor tolerances

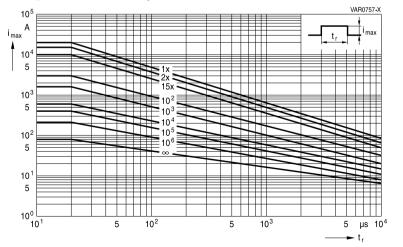


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Derating curves

Maximum surge current $i_{max} = f(t_r, pulse train)$

For explanation of the derating curves refer to "General technical information", section 1.8.1



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Please read *Cautions and warnings* and *Important notes* at the end of this document.



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Cautions and warnings

General

- EPCOS metal oxide varistors are designed for specific applications and should not be used for purposes not identified in our specifications, application notes and data books unless otherwise agreed with EPCOS during the design-in-phase.
- 2. Ensure suitability of SIOVs through reliability testing during the design-in phase. SIOVs should be evaluated taking into consideration worst-case conditions.
- 3. For applications of SIOVs in line-to-ground circuits based on various international and local standards there are restrictions existing or additional safety measures required.

Storage

- 1. Store SIOVs only in original packaging. Do not open the package prior to processing.
- Recommended storage conditions in original packaging: Storage temperature: -25 °C ... +45 °C, Relative humidity: <75% annual average, <95% on maximum 30 days a year. Dew precipitation: is to be avoided.
- 3. Avoid contamination of an SIOV's during storage, handling and processing.
- 4. Avoid storage of SIOVs in harmful environments that can affect the function during long-term operation (examples given under operation precautions).
- 5. The SIOV type series should be soldered after shipment from EPCOS within the time specified:

SIOV-S, -Q, -LS, -B, -SNF 24 months ETFV/ T series, -CU 12 months.

Handling

- 1. SIOVs must not be dropped.
- 2. Components must not be touched with bare hands. Gloves are recommended.
- 3. Avoid contamination of the surface of SIOV electrodes during handling, be careful of the sharp edge of SIOV electrodes.

Soldering (where applicable)

- 1. Use rosin-type flux or non-activated flux.
- 2. Insufficient preheating may cause ceramic cracks.
- 3. Rapid cooling by dipping in solvent is not recommended.
- 4. Complete removal of flux is recommended.
- Temperatures of all preheat stages and the solder bath must be strictly controlled especially for T series (T14 and T20).



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Mounting

- 1. Potting, sealing or adhesive compounds can produce chemical reactions in the SIOV ceramic that will degrade the component's electrical characteristics.
- 2. Overloading SIOVs may result in ruptured packages and expulsion of hot materials. For this reason SIOVs should be physically shielded from adjacent components.

Operation

- 1. Use SIOVs only within the specified temperature operating range.
- 2. Use SIOVs only within the specified voltage and current ranges.
- Environmental conditions must not harm SIOVs. Use SIOVs only in normal atmospheric conditions. Avoid use in deoxidizing gases (chlorine gas, hydrogen sulfide gas, ammonia gas, sulfuric acid gas etc), corrosive agents, humid or salty conditions.Contact with any liquids and solvents should be prevented.

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Symbols and terms

Symbol	Term
C	Capacitance
C _{typ}	Typical capacitance
i	Current
i _c	Current at which $V_{c, max}$ is measured
I _{leak}	Leakage current
İ _{max}	Maximum surge current (also termed peak current)
I _{max}	Maximum discharge current
l _n	Nominal discharge current to UL 1449
LCT	Lower category temperature
L _{typ}	Typical inductance
P _{max}	Maximum average power dissipation
R _{ins}	Insulation resistance
R _{min}	Minimum resistance
T _A	Ambient temperature
t _r	Duration of equivalent rectangular wave
UCT	Upper category temperature
v	Voltage
V_{clamp}	Clamping voltage
V _{c, max}	Maximum clamping voltage at specified current $i_{\mbox{\tiny c}}$
V _{DC}	DC operating voltage
V_{jump}	Maximum jump start voltage
V _{max}	Maximum voltage
V _{op}	Operating voltage
V _{RMS}	AC operating voltage, root-mean-square value
$V_{RMS, op, max}$	Root-mean-square value of max. DC operating voltage incl. ripple current
V _{surge}	Super imposed surge voltage
Vv	Varistor voltage
ΔV_{v}	Tolerance of varistor voltage
W_{LD}	Maximum load dump
W _{max}	Maximum energy absorption
е	Lead spacing

All dimensions are given in mm.

The commas used in numerical values denote decimal points.



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- 1. Some parts of this publication contain statements about the suitability of our products for certain areas of application. These statements are based on our knowledge of typical requirements that are often placed on our products in the areas of application concerned. We nevertheless expressly point out that such statements cannot be regarded as binding statements about the suitability of our products for a particular customer application. As a rule we are either unfamiliar with individual customer applications or less familiar with them than the customers themselves. For these reasons, it is always ultimately incumbent on the customer to check and decide whether a product with the properties described in the product specification is suitable for use in a particular customer application.
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